

Symbol	Parameter		FQD3P50 / FQU3P50	Units
V _{DSS}	Drain-Source Voltage		-500	V
I _D	Drain Current - Continuous ($T_C = 25^\circ$	C)	-2.1	А
	- Continuous (T _C = 100	°C)	-1.33	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-8.4	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
I _{AR}	Avalanche Current	(Note 1)	-2.1	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
PD	Power Dissipation ($T_A = 25^{\circ}C$) *		2.5	W
	Power Dissipation ($T_C = 25^{\circ}C$)		50	W
	- Derate above 25°C	-	0.4	W/°C

Thermal Characteristics

Operating and Storage Temperature Range

1/8" from case for 5 seconds

Maximum lead temperature for soldering purposes,

Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

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T_J, T_{STG}

 T_L

°C

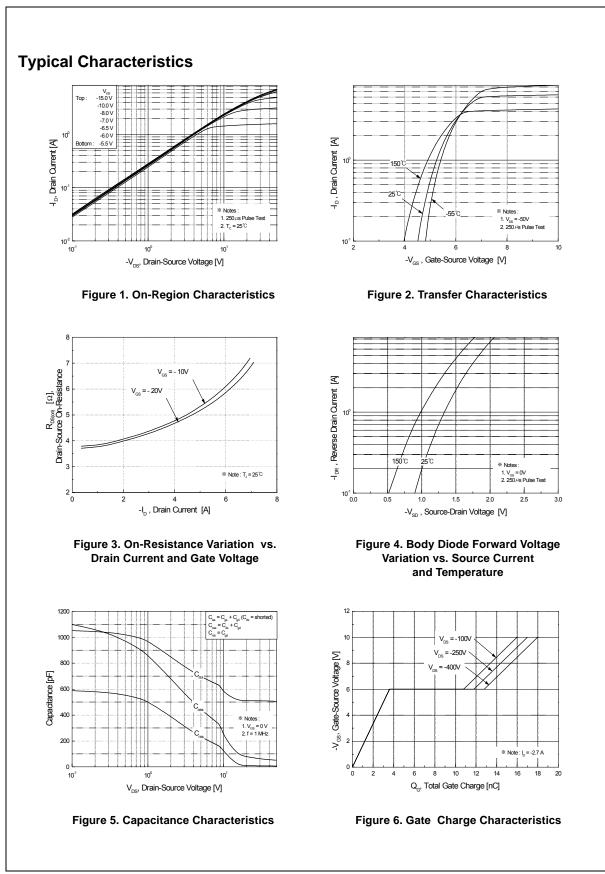
°C

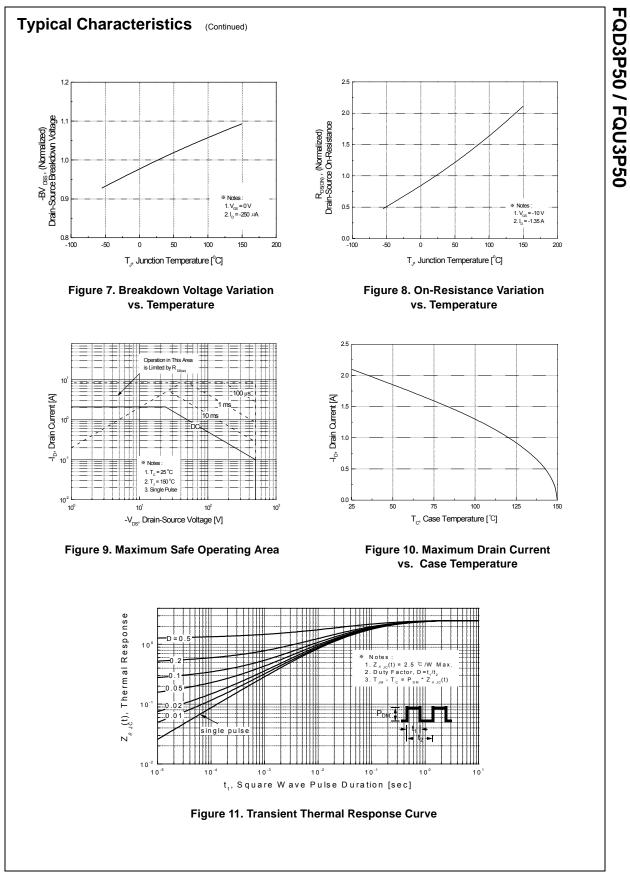
-55 to +150

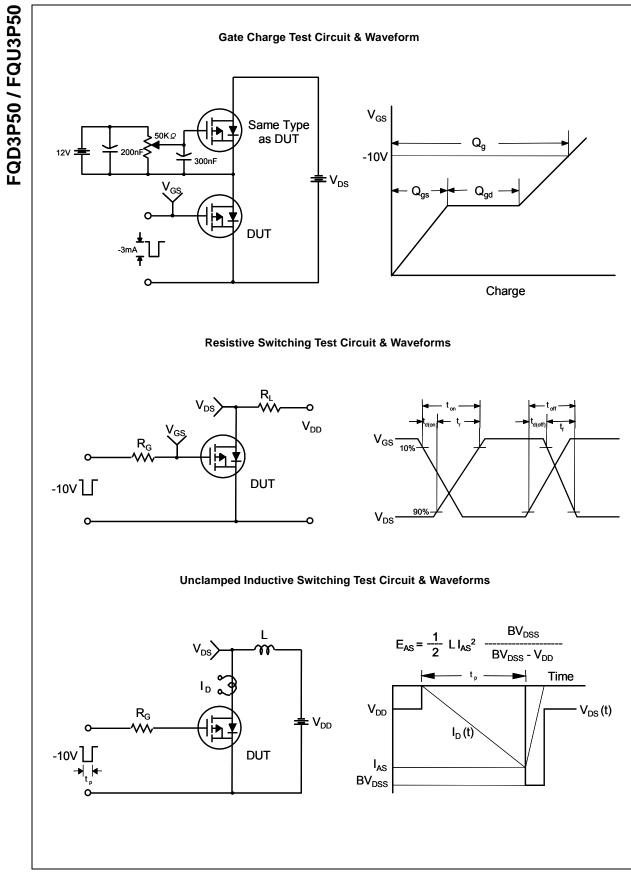
300

$ \Delta T_{J} Coefficient \qquad I_{D} = -250 \ \mu A, Referenced to 25 \ C \qquad \qquad 0.42 $ $ DSS \qquad Zero Gate Voltage Drain Current \qquad V_{DS} = -500 \ V, V_{GS} = 0 \ V \qquad \qquad \qquad V_{DS} = -400 \ V, T_{C} = 125^{\circ}C \qquad \qquad \qquad \qquad V_{DS} = -400 \ V, T_{C} = 125^{\circ}C \qquad \qquad$	100 nA 100 nA -5.0 V 4.9 Ω S 660 pF 90 pF	0.42 10 100 100 100 3.9 4.9	0.42 -3.0		$I_{D} = -250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = -500 \ \text{V}, \ V_{GS} = 0 \ \text{V}$ $V_{DS} = -400 \ \text{V}, \ T_{C} = 125^{\circ}\text{C}$ $V_{GS} = -30 \ \text{V}, \ V_{DS} = 0 \ \text{V}$	Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward	BV _{DSS} ΔBV _{DSS} ΔT _J
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	 V/°C -1 μA -10 μA 100 nA 100 nA 5.0 V 4.9 Ω S 660 pF 90 pF 	0.42 10 100 100 100 3.9 4.9	0.42 -3.0		$I_{D} = -250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = -500 \ \text{V}, \ V_{GS} = 0 \ \text{V}$ $V_{DS} = -400 \ \text{V}, \ T_{C} = 125^{\circ}\text{C}$ $V_{GS} = -30 \ \text{V}, \ V_{DS} = 0 \ \text{V}$	Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward	BV _{DSS} ΔBV _{DSS} ΔT _J
$ \Delta T_{J} Coefficient \qquad I_{D} = -250 \ \mu A, Referenced to 25 \ C \qquad \qquad 0.42 $ $ DSS \qquad Zero Gate Voltage Drain Current \qquad \frac{V_{DS} = -500 \ V, V_{GS} = 0 \ V \qquad \qquad \qquad \qquad \qquad \qquad \qquad $	-1 μA -10 μA 100 nA 100 nA -5.0 V 4.9 Ω S 660 pF 90 pF	1 10 100 100 100 3.9 4.9	 -3.0		$V_{DS} = -500 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -400 \text{ V}, T_{C} = 125^{\circ}\text{C}$ $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward	$\Delta T_{\rm J}$
Zero Gate Voltage Drain Current $V_{DS} = -400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$ GSSFGate-Body Leakage Current, Forward $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ GSSRGate-Body Leakage Current, Reverse $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ On Characteristics//GS(th)Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250 \mu \text{ A}$ 3.0Physical Characteristics//GS(on)Static Drain-Source On-Resistance $V_{GS} = -10 \text{ V}, I_D = -1.05 \text{ A}$ 3.9Optimic CharacteristicsOptimic CharacteristicsClassInput Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, I_D = -1.05 \text{ A}$ 5106ClassOutput Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, I_D = -1.05 \text{ A}$ 9.5Optimic CharacteristicsClassInput Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, I_D = -2.7 \text{ A}, I_D = -$	-10 μA 100 nA 100 nA -5.0 V 4.9 Ω S 660 pF 90 pF	10 100 100 5.0 3.9 4.9	 -3.0		$V_{DS} = -400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$ $V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Gate-Body Leakage Current, Forward	DSS
Gate-Body Leakage Current, Forward $V_{GS} = -400$ V, $V_{C} = 125^{\circ}C$ GSSFGate-Body Leakage Current, Reverse $V_{GS} = -30$ V, $V_{DS} = 0$ VGSSRGate-Body Leakage Current, Reverse $V_{GS} = 30$ V, $V_{DS} = 0$ VOn Characteristics $V_{GS}(th)$ Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250$ μ A $P_{S}(on)$ Static Drain-Source On-Resistance $V_{GS} = -10$ V, $I_D = -1.05$ A3.9 Q_{FS} Forward Transconductance $V_{DS} = -50$ V, $I_D = -1.05$ A2.1 $Optimic CharacteristicsV_{DS} = -25 V, V_{GS} = 0 V,f = 1.0 MHz5106C_{rss}Input CapacitanceV_{DS} = -25 V, V_{GS} = 0 V,f = 1.0 MHz9.5C_{rss}Reverse Transfer CapacitanceV_{DS} = -25 V, V_{GS} = 0 V,f = 1.0 MHz9.5C_{rss}Reverse Transfer CapacitanceV_{DD} = -250 V, I_D = -2.7 A,R_G = 25 \Omega12C_{rss}Turn-On Delay TimeTurn-On Rise TimeV_{DD} = -250 V, I_D = -2.7 A,R_G = 25 \Omega12C_{rss}Turn-Off Delay TimeTurn-Off Fall Time35C_{rss}Turn-Off Fall Time35C_{rss}Turn-Off Fall Time451$	100 nA 100 nA -5.0 V 4.9 Ω S 660 pF 90 pF	100 100 5.0 3.9 4.9	 -3.0		$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Gate-Body Leakage Current, Forward	
GostGate-Body Leakage Current, Reverse $V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$ 1On Characteristics $V_{GS}(th)$ Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250 \mu \text{A}$ -3.0 $R_{S}(on)$ Static Drain-Source On-Resistance $V_{GS} = -10 \text{ V}, I_D = -1.05 \text{ A}$ 3.9 QFS Forward Transconductance $V_{DS} = -50 \text{ V}, I_D = -1.05 \text{ A}$ 2.1Optimize Characteristics C_{ISS} Input Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ 5106 C_{ISS} Output Capacitance $f = 1.0 \text{ MHz}$ 9.5Switching Characteristics $d(on)$ Turn-On Delay Time r $V_{DD} = -250 \text{ V}, I_D = -2.7 \text{ A},$ $R_G = 25 \Omega$ 12 $(Note 4, 5)$ 561 $d(off)$ Turn-Off Delay Time f $(Note 4, 5)$ 35 f Turn-Off Fall Time $(Note 4, 5)$ 451	100 nA -5.0 V 4.9 Ω S 660 pF 90 pF	100 5.0 3.9 4.9			55		
On Characteristics $V_{GS(th)}$ Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -3.0 $$ -3.0 $$ $R_{DS(on)}$ Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -1.05 \ A$ $$ 3.9 $$ QFS Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -1.05 \ A$ $$ 2.1 Oppnamic Characteristics C_{ISS} Input Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, $f = 1.0 \ MHz$ $$ $510 \ C$ CossOutput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, $f = 1.0 \ MHz$ $$ $70 \ C$ Switching Characteristicsd(on)Turn-On Delay Time r $V_{DD} = -250 \ V$, $I_D = -2.7 \ A$, $R_G = 25 \ \Omega$ $$ $12 \$ fTurn-Off Delay Time r $V_{DD} = -250 \ V$, $I_D = -2.7 \ A$, $R_G = 25 \ \Omega$ $$ $12 \$ fTurn-Off Fall Time $V_{DD} = -250 \ V$, $I_D = -2.7 \ A$, $R_G = 25 \ \Omega$ $$ $12 \$ fTurn-Off Fall Time $V_{DD} = -250 \ V$, $I_D = -2.7 \ A$, $$ $$ $12 \$ fTurn-Off Fall Time $$ $35 \$ $12 \$ fTurn-Off Fall Time $$ $35 \$ $12 \$ fTurn-Off Fall Time $$ $45 \$ $145 \$	-5.0 V 4.9 Ω S 660 pF 90 pF	5.0 3.9 4.9	-3.0	1	V _{GS} = 30 V, V _{DS} = 0 V	Gate-Body Leakage Current, Reverse	GSSF
	4.9 Ω S 660 pF 90 pF	3.9 4.9		20		,	GSSR
	4.9 Ω S 660 pF 90 pF	3.9 4.9		2.0		racteristics	On Cha
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	S 660 pF 90 pF			-3.0	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	t	
Dynamic CharacteristicsDissInput Capacitance $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ 51060CossOutput Capacitancef = 1.0 MHz70CrssReverse Transfer Capacitance9.59.5Switching Characteristicsd(on)Turn-On Delay Time $V_{DD} = -250 \text{ V}, \text{ I}_D = -2.7 \text{ A},$ 12rTurn-On Rise Time $R_G = 25 \Omega$ 561d(off)Turn-Off Delay Time(Note 4, 5)451	660 pF 90 pF	2.1	3.9		V _{GS} = -10 V, I _D = -1.05 A		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	90 pF	2.1	2.1		V _{DS} = -50 V, I _D = -1.05 A (Note 4)	Forward Transconductance	JFS
CossOutput Capacitance r_{DS}	90 pF	-10 000	540		Ι		
C_{rss} Reverse Transfer Capacitance9.5Switching Characteristics $d(on)$ Turn-On Delay Time $V_{DD} = -250 \text{ V}, \text{ I}_D = -2.7 \text{ A},$ 12 $$ Turn-On Rise Time $R_G = 25 \Omega$ 561 $d(off)$ Turn-Off Delay Time35451							
Switching Characteristics $d(on)$ Turn-On Delay Time $V_{DD} = -250 \text{ V}, \text{ I}_D = -2.7 \text{ A},$ 12rTurn-On Rise Time $R_G = 25 \Omega$ 561 $d(off)$ Turn-Off Delay Time(Note 4, 5)35fTurn-Off Fall Time451			-		t = 1.0 MHz		
d(off) Turn-Off Delay Time 35 Turn-Off Fall Time (Note 4, 5) 45 1	35 ns				V _{DD} = -250 V, I _D = -2.7 A,	Turn-On Delay Time	d(on)
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	35 ns	12 35	12				
f Turn-Off Fall Time (Note 4, 5) 45	120 ns	56 120	56			Turn-On Rise Time	
					(Note 4 E)	,	
	100 ns	45 100	45		(Note 4, 5)	Turn-Off Fall Time	
	23 nC	18 23	18		V_{DS} = -400 V, I_{D} = -2.7 A,	Total Gate Charge	ל ^g
Q_{gs} Gate-Source Charge $V_{GS} = -10 V$ 3.6	nC					•	-
Q _{gd} Gate-Drain Charge (Note 4, 5) 9.2	nC	9.2	9.2		(Note 4, 5)	Gate-Drain Charge	2 _{gd}
Drain-Source Diode Characteristics and Maximum Ratings					nd Maximum Ratings	ource Diode Characteristics ar	Drain-S
S Maximum Continuous Drain-Source Diode Forward Current	-2.1 A	2.1					S
SM Maximum Pulsed Drain-Source Diode Forward Current	-8.4 A	8.4			Forward Current	Maximum Pulsed Drain-Source Diode F	SM
V_{SD} Drain-Source Diode Forward Voltage V_{GS} = 0 V, I_S = -2.1 A	-5.0 V	5.0			V _{GS} = 0 V, I _S = -2.1 A	Drain-Source Diode Forward Voltage	/ _{SD}
$V_{GS} = 0 V, I_S = -2.7 A,270$	ns	270	270		V _{GS} = 0 V, I _S = -2.7 A,	Reverse Recovery Time	rr
Q_{rr} Reverse Recovery Charge $dI_F / dt = 100 \text{ A/}\mu \text{s}$ (Note 4) 1.5	μC	1.5	1.5		$dI_{F} / dt = 100 A/\mu s$ (Note 4)	Reverse Recovery Charge	շ ^{ու}
tes:Repetitive Rating : Pulse width limited by maximum junction temperature $_{-}$ = 102mH, I_{AS} = -2.1A, V_{DD} = -50V, R_{G} = 25 Ω , Starting T_{J} = 25°C I_{SD} \leq -2.7A, di/dt \leq 200A/µs, V_{DD} \leq BV _{DSS} , Starting T_{J} = 25°CPulse Test : Pulse width \leq 300µs, Duty cycle \leq 2%						$ \begin{array}{l} I_{AS} \stackrel{=}{=} -2.1A, V_{DD} \stackrel{=}{=} -50V, R_{G} \stackrel{=}{=} 25 \Omega, Starting T_{J} \stackrel{=}{=} 25 ^{\circ}C \\ , di/dt \leq 200A/\mus, V_{DD} \leq BV_{DSS}, Starting T_{J} \stackrel{=}{=} 25 ^{\circ}C \end{array} $	Repetitive R L = 102mH, $_{SD} \leq -2.7A$
Essentially independent of operating temperature							

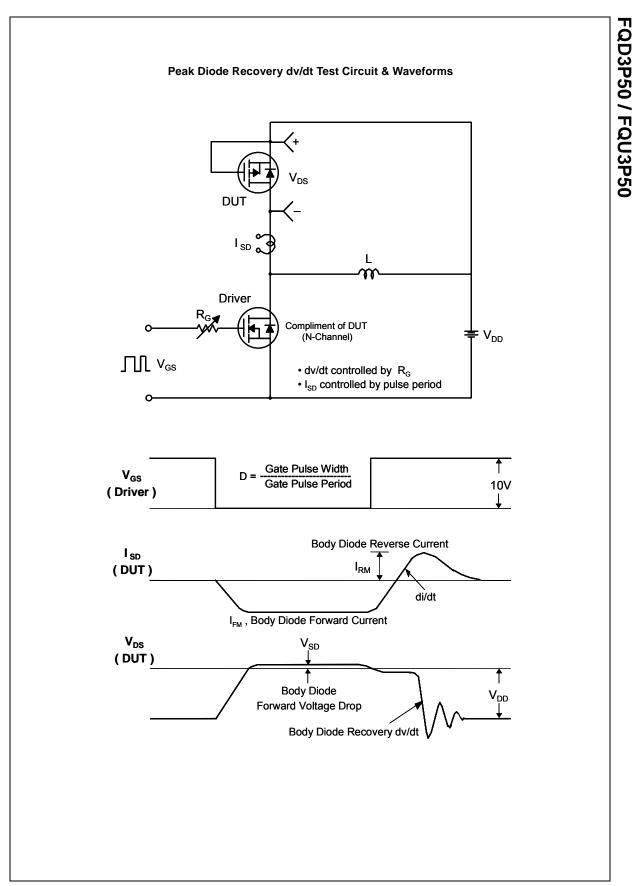




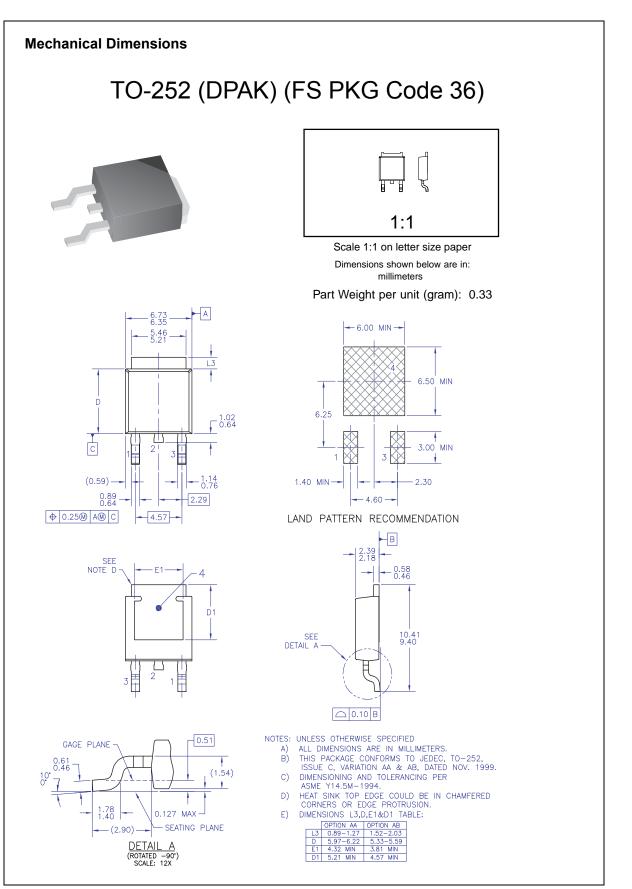




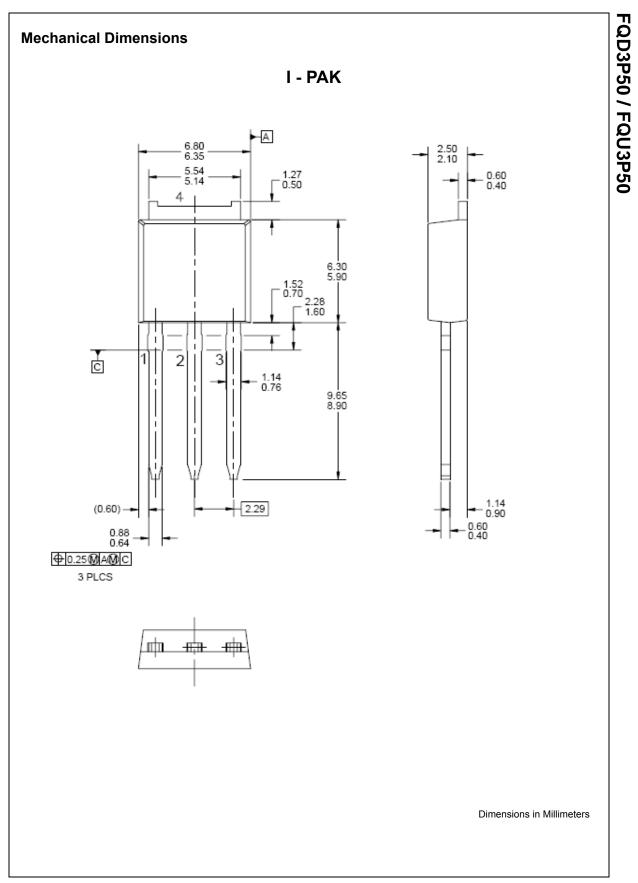
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